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12	AG	2001-182814	7/6/2001	Japan				xx	_	
	АН	2003-278901	10/2/2003	Japan						xx
	Al	2003-262266	9/19/2003	Japan				_		xx
	AJ	2003-074683	3/12/2003	Japan						xx
	AK	2003-172444	6/20/2003	Japan						xx
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FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE	ATTY, DOCKET NO.	SERIAL NO.			
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12	BG	2002-115579	4/19/2002	Japan .				xx
	вн	2000-264096	9/26/2000	Japan				xx
	ВІ	2000-052816	2/22/2000	Japan				xx
	BJ	2002-039353	2/6/2002	Japan				xx
V	ВК	11-303981	11/2/1999	, Japan				xx
186	BL	2001-099282	4/10/2001	Japan				xx

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)									
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124	CG	08-014076	1/16/1996	Japan						хх
	СН	2002-309985	10/23/2002	Japan						хх
	CI	2003-240110	8/27/2003	Japan						xx
101	CJ	2003-294122	10/15/2003	Japan						xx

		OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)	
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